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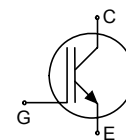
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# IGP03N120H2 IGW03N120H2

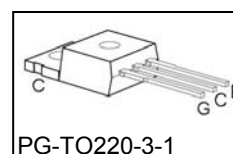
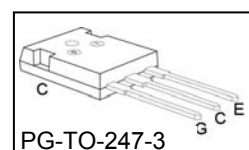
## HighSpeed 2-Technology

- Designed for:
  - SMPS
  - Lamp Ballast
  - ZVS-Converter
  - optimised for soft-switching / resonant topologies



- 2<sup>nd</sup> generation HighSpeed-Technology for 1200V applications offers:

- loss reduction in resonant circuits
- temperature stable behavior
- parallel switching capability
- tight parameter distribution
- $E_{off}$  optimized for  $I_C = 3A$



- Qualified according to JEDEC<sup>2</sup> for target applications
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models : <http://www.infineon.com/igbt/>

| Type        | $V_{CE}$ | $I_C$ | $E_{off}$ | $T_j$ | Marking  | Package       |
|-------------|----------|-------|-----------|-------|----------|---------------|
| IGW03N120H2 | 1200V    | 3A    | 0.15mJ    | 150°C | G03H1202 | PG-TO-247-3   |
| IGP03N120H2 | 1200V    | 3A    | 0.15mJ    | 150°C | G03H1202 | PG-TO-220-3-1 |

### Maximum Ratings

| Parameter  | Symbol         | Value      | Unit |
|--|----------------|------------|------|
| Collector-emitter voltage                                  | $V_{CE}$       | 1200       | V    |
| Triangular collector current                               | $I_C$          | 9.6<br>3.9 | A    |
| $T_C = 25^\circ\text{C}, f = 140\text{kHz}$                |                |            |      |
| $T_C = 100^\circ\text{C}, f = 140\text{kHz}$               |                |            |      |
| Pulsed collector current, $t_p$ limited by $T_{jmax}$      | $I_{Cpuls}$    | 9.9        |      |
| Turn off safe operating area                               | -              | 9.9        |      |
| $V_{CE} \leq 1200\text{V}, T_j \leq 150^\circ\text{C}$     |                |            |      |
| Gate-emitter voltage                                       | $V_{GE}$       | $\pm 20$   | V    |
| Power dissipation  | $P_{tot}$      | 62.5       | W    |
| $T_C = 25^\circ\text{C}$                                   |                |            |      |
| Operating junction and storage temperature                 | $T_j, T_{stg}$ | -40...+150 | °C   |
| Soldering temperature, 1.6mm (0.063 in.) from case for 10s | -              | 260        |      |

<sup>2</sup> J-STD-020 and JESD-022



# IGP03N120H2 IGW03N120H2

## Thermal Resistance

| Parameter                                | Symbol     | Conditions                   | Max. Value | Unit |
|--|------------|------------------------------|------------|------|
| <b>Characteristic</b>                    |            |                              |            |      |
| IGBT thermal resistance, junction – case | $R_{thJC}$ |                              | 2.0        | K/W  |
| Thermal resistance, junction – ambient   | $R_{thJA}$ | PG-TO-220-3-1<br>PG-TO-247-3 | 62<br>40   |      |

## Electrical Characteristic, at $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter  | Symbol        | Conditions   | Value       |                   |               | Unit    |
|--|---------------|--|-------------|-------------------|---------------|---------|
|  |               |  | min.        | Typ.              | max.          |         |
| <b>Static Characteristic</b>                                   |               |  |             |                   |               |         |
| Collector-emitter breakdown voltage                            | $V_{(BR)CES}$ | $V_{GE}=0V, I_C=300\mu A$  | 1200        | -                 | -             | V       |
| Collector-emitter saturation voltage                           | $V_{CE(sat)}$ | $V_{GE} = 15V, I_C=3A$<br>$T_j=25^\circ\text{C}$<br>$T_j=150^\circ\text{C}$<br>$V_{GE} = 10V, I_C=3A,$<br>$T_j=25^\circ\text{C}$ | -<br>-<br>- | 2.2<br>2.5<br>2.4 | 2.8<br>-<br>- |         |
| Gate-emitter threshold voltage                                 | $V_{GE(th)}$  | $I_C=90\mu A, V_{CE}=V_{GE}$   | 2.1         | 3                 | 3.9           |         |
| Zero gate voltage collector current                            | $I_{CES}$     | $V_{CE}=1200V, V_{GE}=0V$<br>$T_j=25^\circ\text{C}$<br>$T_j=150^\circ\text{C}$   | -<br>-      | -<br>-            | 20<br>80      | $\mu A$ |
| Gate-emitter leakage current                                   | $I_{GES}$     | $V_{CE}=0V, V_{GE}=20V$  | -           | -                 | 100           | nA      |
| Transconductance   | $g_{fs}$      | $V_{CE}=20V, I_C=3A$   | -           | 2                 | -             | S       |
| <b>Dynamic Characteristic</b>                                  |               |  |             |                   |               |         |
| Input capacitance  | $C_{iss}$     | $V_{CE}=25V,$<br>$V_{GE}=0V,$<br>$f=1\text{MHz}$   | -           | 205               | -             | pF      |
| Output capacitance   | $C_{oss}$     |  | -           | 24                | -             |         |
| Reverse transfer capacitance                                   | $C_{riss}$    |  | -           | 7                 | -             |         |
| Gate charge  | $Q_{Gate}$    | $V_{CC}=960V, I_C=3A$<br>$V_{GE}=15V$  | -           | 22                | -             | nC      |
| Internal emitter inductance measured 5mm (0.197 in.) from case | $L_E$         | PG-TO-220-3-1<br>PG-TO-247-3   | -<br>-      | 7<br>13           | -<br>-        | nH      |



# IGP03N120H2 IGW03N120H2

**Switching Characteristic, Inductive Load, at  $T_j=25^\circ\text{C}$** 

| Parameter                  | Symbol       | Conditions   | Value |      |      | Unit |
|----------------------------|--------------|--|-------|------|------|------|
|                            |              |  | min.  | typ. | max. |      |
| <b>IGBT Characteristic</b> |              |  |       |      |      |      |
| Turn-on delay time         | $t_{d(on)}$  | $T_j=25^\circ\text{C}$ ,   | -     | 9.2  | -    | ns   |
| Rise time                  | $t_r$        | $V_{CC}=800\text{V}$ , $I_C=3\text{A}$ ,                               | -     | 5.2  | -    |      |
| Turn-off delay time        | $t_{d(off)}$ | $V_{GE}=15\text{V}/0\text{V}$ ,  | -     | 281  | -    |      |
| Fall time                  | $t_f$        | $R_G=82\Omega$ ,   | -     | 29   | -    |      |
| Turn-on energy             | $E_{on}$     | $L_\sigma^{(2)}=180\text{nH}$ ,  | -     | 0.14 | -    | mJ   |
| Turn-off energy            | $E_{off}$    | $C_\sigma^{(2)}=40\text{pF}$   | -     | 0.15 | -    |      |
| Total switching energy     | $E_{ts}$     | Energy losses include "tail" and diode <sup>3)</sup> reverse recovery. | -     | 0.29 | -    |      |

**Switching Characteristic, Inductive Load, at  $T_j=150^\circ\text{C}$** 

| Parameter                  | Symbol       | Conditions   | Value |      |      | Unit |
|----------------------------|--------------|--|-------|------|------|------|
|                            |              |  | min.  | typ. | max. |      |
| <b>IGBT Characteristic</b> |              |  |       |      |      |      |
| Turn-on delay time         | $t_{d(on)}$  | $T_j=150^\circ\text{C}$  | -     | 9.4  | -    | ns   |
| Rise time                  | $t_r$        | $V_{CC}=800\text{V}$ ,   | -     | 6.7  | -    |      |
| Turn-off delay time        | $t_{d(off)}$ | $I_C=3\text{A}$ ,  | -     | 340  | -    |      |
| Fall time                  | $t_f$        | $V_{GE}=15\text{V}/0\text{V}$ ,  | -     | 63   | -    |      |
| Turn-on energy             | $E_{on}$     | $R_G=82\Omega$ ,   | -     | 0.22 | -    | mJ   |
| Turn-off energy            | $E_{off}$    | $L_\sigma^{(2)}=180\text{nH}$ ,  | -     | 0.26 | -    |      |
| Total switching energy     | $E_{ts}$     | $C_\sigma^{(2)}=40\text{pF}$<br>Energy losses include "tail" and diode <sup>3)</sup> reverse recovery. | -     | 0.48 | -    |      |

**Switching Energy ZVT, Inductive Load**

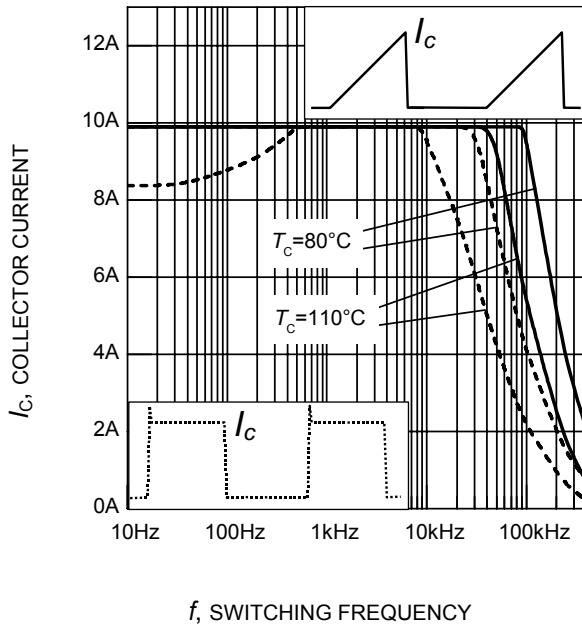
| Parameter                  | Symbol    | Conditions                      | Value |      |      | Unit |
|----------------------------|-----------|---------------------------------|-------|------|------|------|
|                            |           |                                 | min.  | typ. | max. |      |
| <b>IGBT Characteristic</b> |           |                                 |       |      |      |      |
| Turn-off energy            | $E_{off}$ | $V_{CC}=800\text{V}$ ,          |       |      |      | mJ   |
|                            |           | $I_C=3\text{A}$ ,               |       |      |      |      |
|                            |           | $V_{GE}=15\text{V}/0\text{V}$ , |       |      |      |      |
|                            |           | $R_G=82\Omega$ ,                |       |      |      |      |
|                            |           | $C_r^{(2)}=4\text{nF}$          |       |      |      |      |
|                            |           | $T_j=25^\circ\text{C}$          | -     | 0.05 | -    |      |
|                            |           | $T_j=150^\circ\text{C}$         | -     | 0.09 | -    |      |

<sup>2)</sup> Leakage inductance  $L_\sigma$  and stray capacity  $C_\sigma$  due to dynamic test circuit in figure E

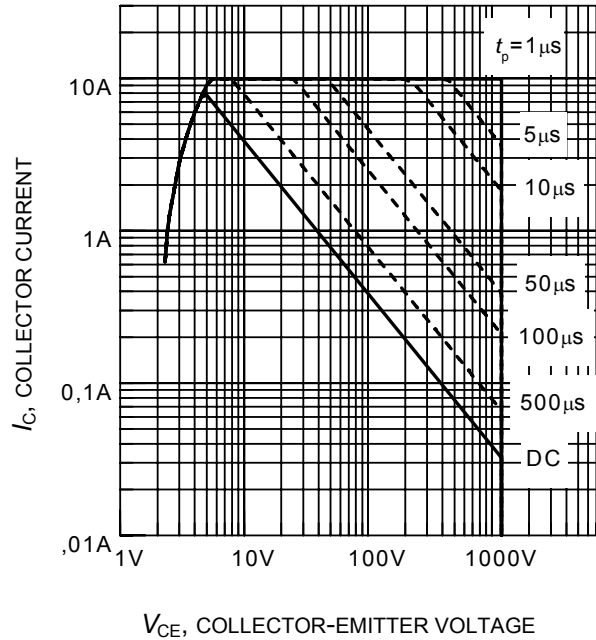
<sup>3)</sup> Commutation diode from device IKP03N120H2



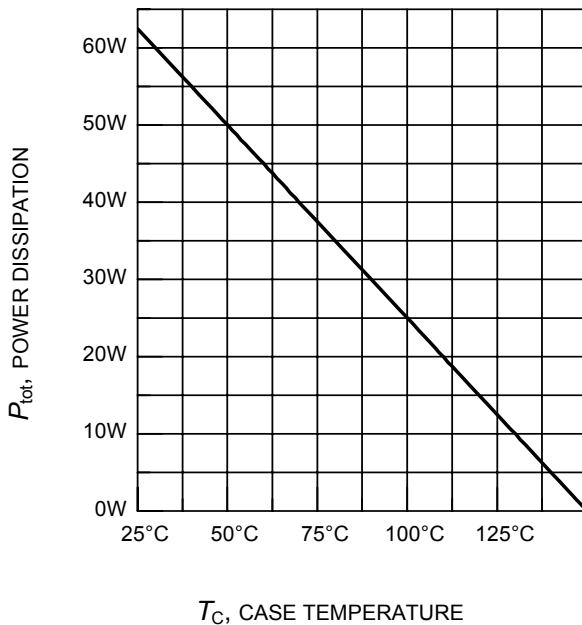
**IGP03N120H2**  
**IGW03N120H2**



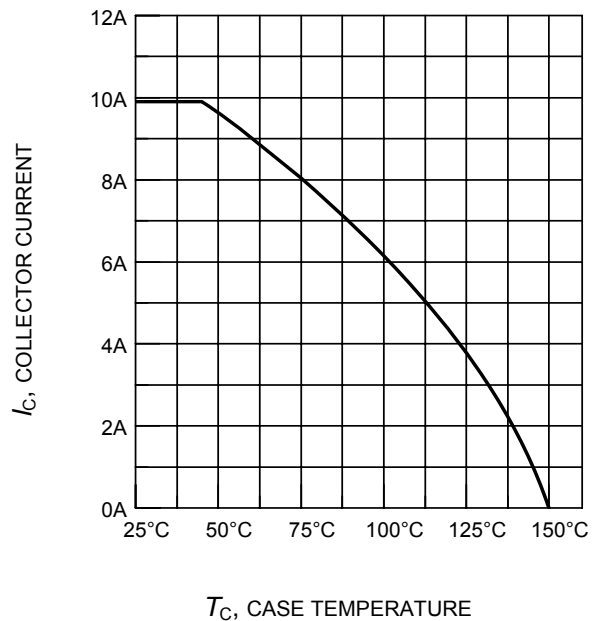
**Figure 1. Collector current as a function of switching frequency**  
( $T_j \leq 150^\circ\text{C}$ ,  $D = 0.5$ ,  $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $R_G = 82\Omega$ )



**Figure 2. Safe operating area**  
( $D = 0$ ,  $T_C = 25^\circ\text{C}$ ,  $T_j \leq 150^\circ\text{C}$ )



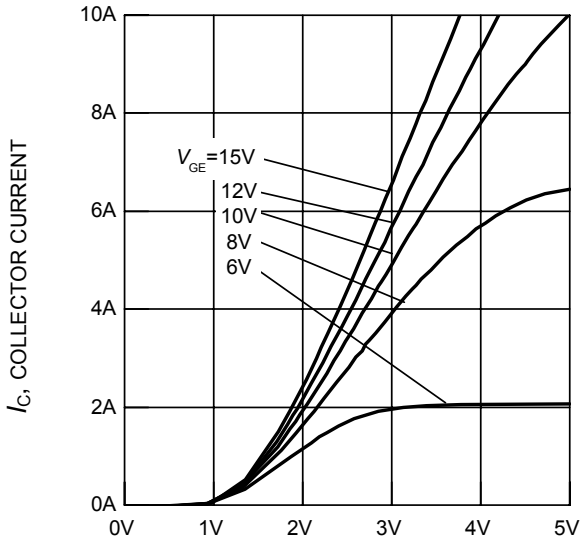
**Figure 3. Power dissipation as a function of case temperature**  
( $T_j \leq 150^\circ\text{C}$ )



**Figure 4. Collector current as a function of case temperature**  
( $V_{GE} \leq 15\text{V}$ ,  $T_j \leq 150^\circ\text{C}$ )

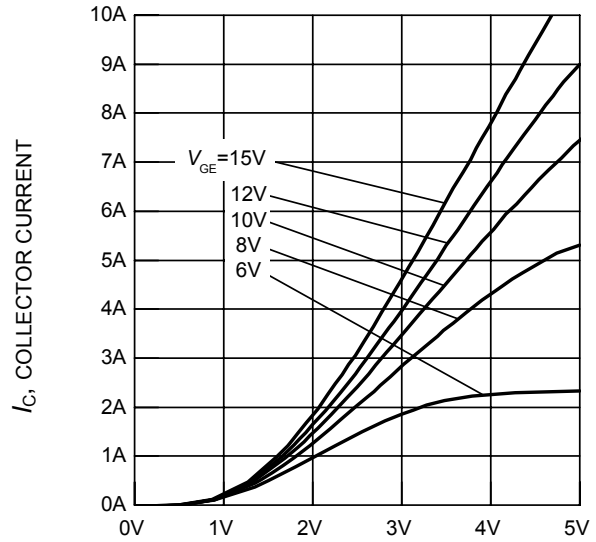


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**IGW03N120H2**



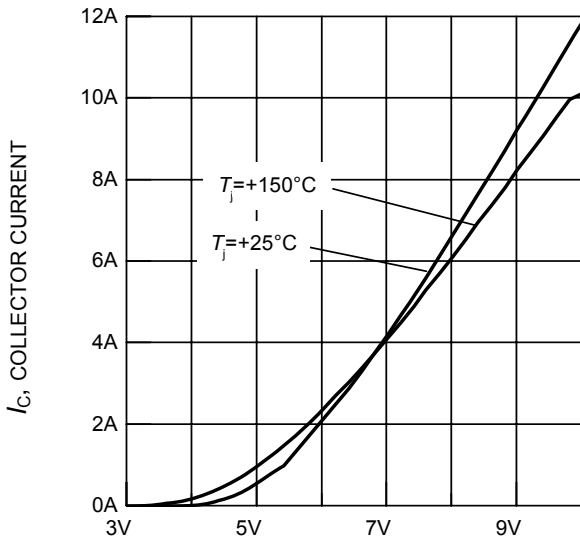
$V_{CE}$ , COLLECTOR-EMITTER VOLTAGE

**Figure 5. Typical output characteristics**  
( $T_j = 25^\circ\text{C}$ )



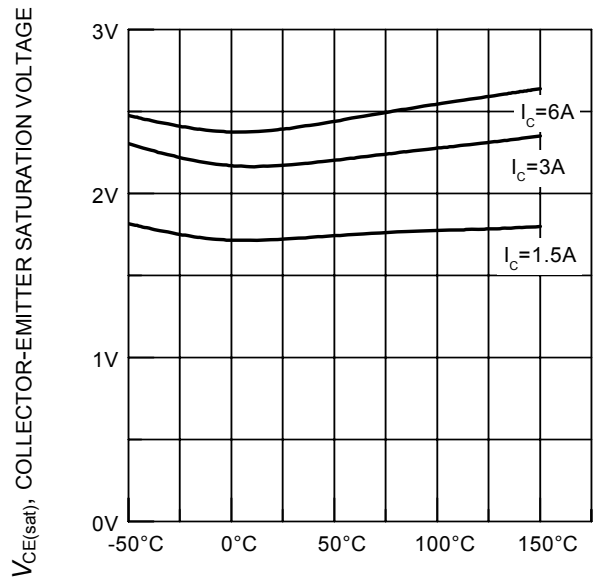
$V_{CE}$ , COLLECTOR-EMITTER VOLTAGE

**Figure 6. Typical output characteristics**  
( $T_j = 150^\circ\text{C}$ )



$V_{GE}$ , GATE-EMITTER VOLTAGE

**Figure 7. Typical transfer characteristics**  
( $V_{CE} = 20\text{V}$ )

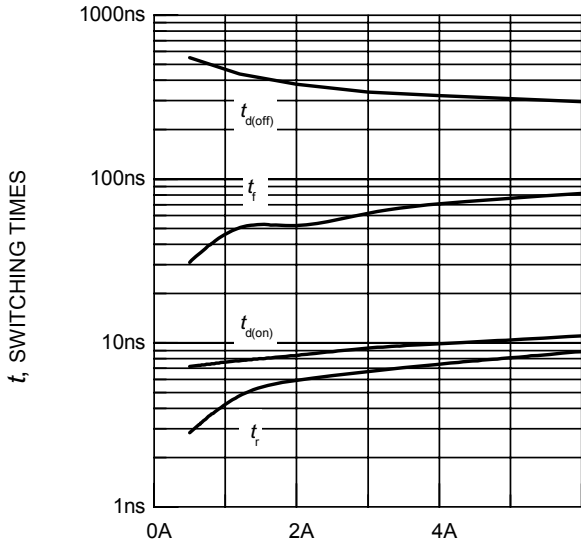


$T_j$ , JUNCTION TEMPERATURE

**Figure 8. Typical collector-emitter saturation voltage as a function of junction temperature**  
( $V_{GE} = 15\text{V}$ )



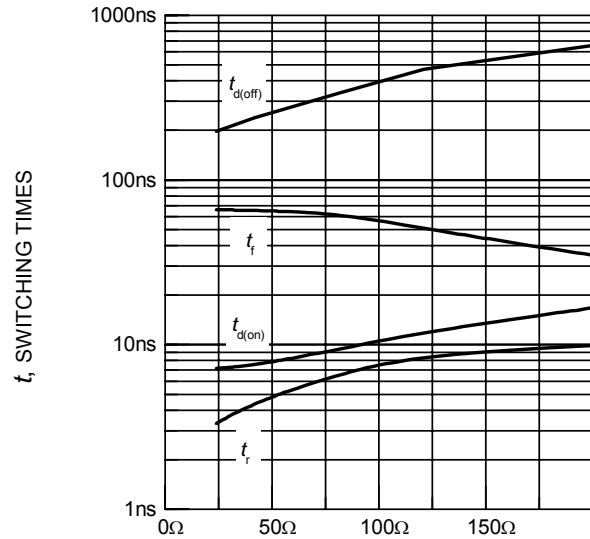
**IGP03N120H2**  
**IGW03N120H2**



$I_C$ , COLLECTOR CURRENT

**Figure 9. Typical switching times as a function of collector current**

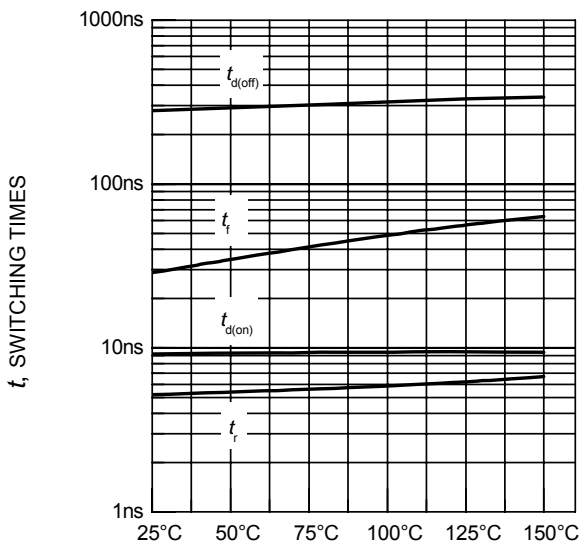
(inductive load,  $T_j = 150^\circ\text{C}$ ,  $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $R_G = 82\Omega$ , dynamic test circuit in Fig.E)



$R_G$ , GATE RESISTOR

**Figure 10. Typical switching times as a function of gate resistor**

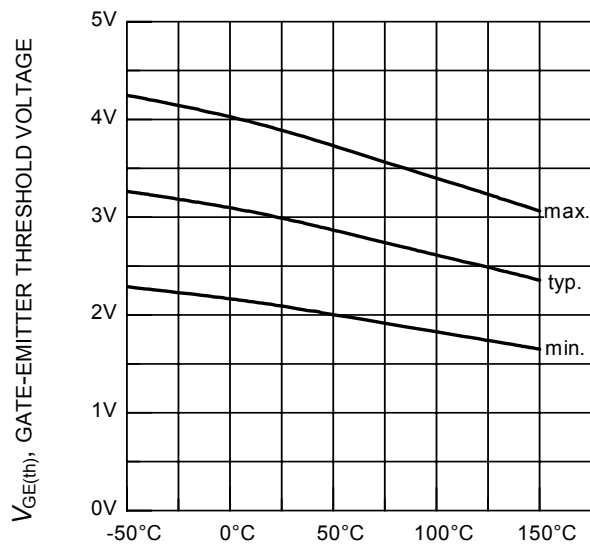
(inductive load,  $T_j = 150^\circ\text{C}$ ,  $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $I_C = 3\text{A}$ , dynamic test circuit in Fig.E)



$T_j$ , JUNCTION TEMPERATURE

**Figure 11. Typical switching times as a function of junction temperature**

(inductive load,  $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $I_C = 3\text{A}$ ,  $R_G = 82\Omega$ , dynamic test circuit in Fig.E)



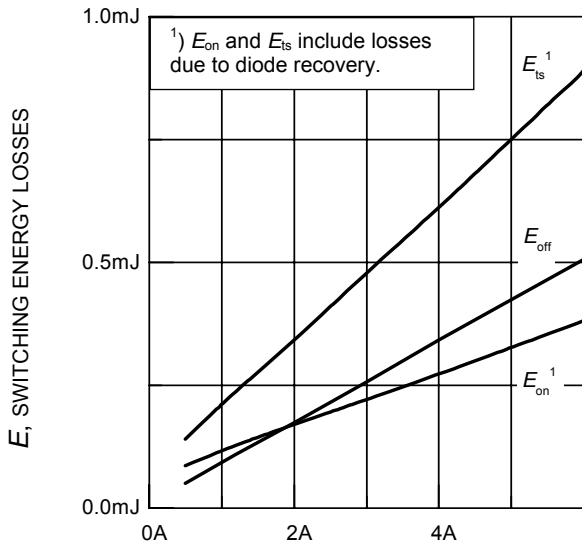
$T_j$ , JUNCTION TEMPERATURE

**Figure 12. Gate-emitter threshold voltage as a function of junction temperature**

( $I_C = 0.09\text{mA}$ )



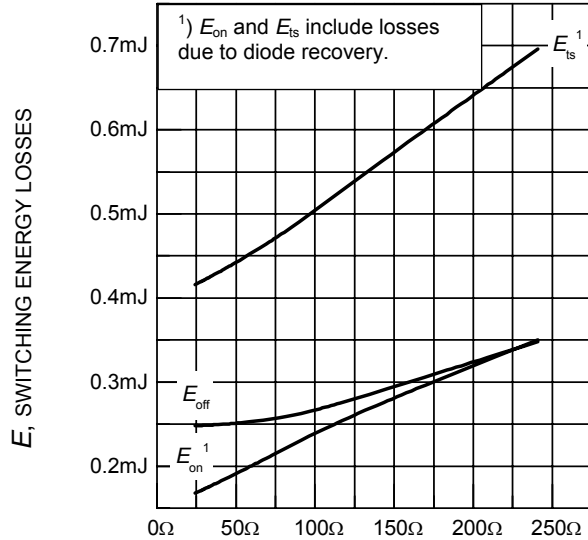
**IGP03N120H2**  
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$I_C$ , COLLECTOR CURRENT

**Figure 13. Typical switching energy losses as a function of collector current**

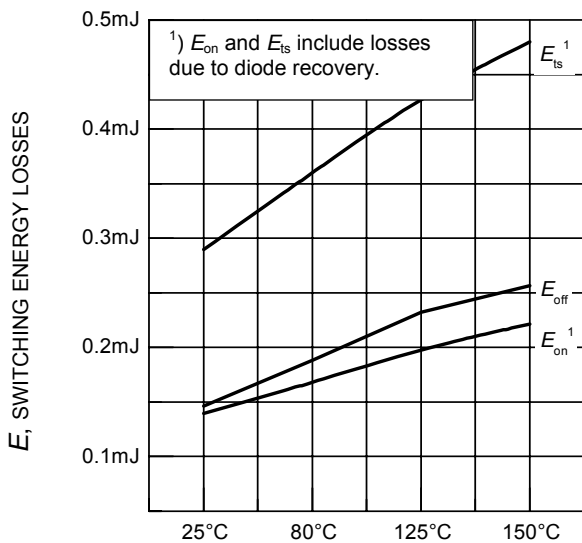
(inductive load,  $T_j = 150^\circ\text{C}$ ,  $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $R_G = 82\Omega$ , dynamic test circuit in Fig.E )



$R_G$ , GATE RESISTOR

**Figure 14. Typical switching energy losses as a function of gate resistor**

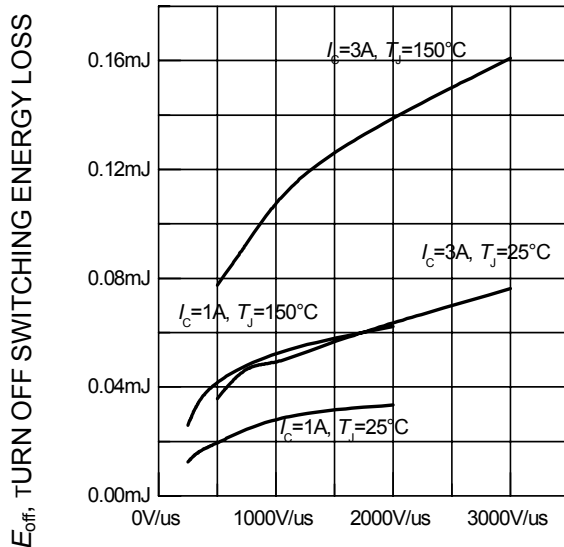
(inductive load,  $T_j = 150^\circ\text{C}$ ,  $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $I_C = 3\text{A}$ , dynamic test circuit in Fig.E )



$T_j$ , JUNCTION TEMPERATURE

**Figure 15. Typical switching energy losses as a function of junction temperature**

(inductive load,  $V_{CE} = 800\text{V}$ ,  $V_{GE} = +15\text{V}/0\text{V}$ ,  $I_C = 3\text{A}$ ,  $R_G = 82\Omega$ , dynamic test circuit in Fig.E )



$dv/dt$ , VOLTAGE SLOPE

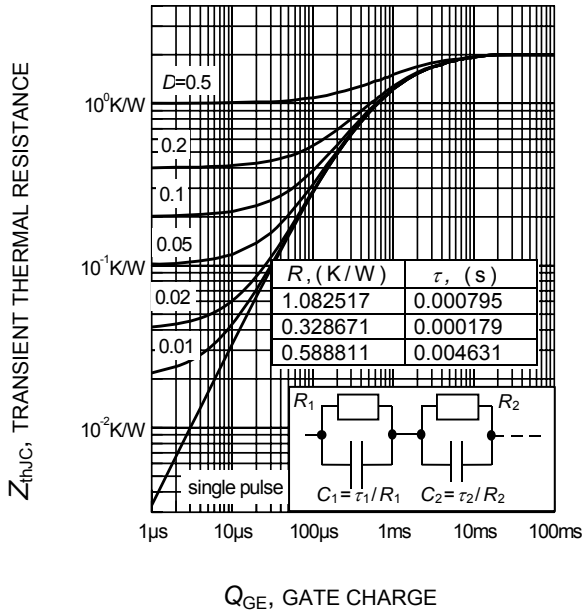
**Figure 16. Typical turn off switching energy loss for soft switching**

(dynamic test circuit in Fig. E)

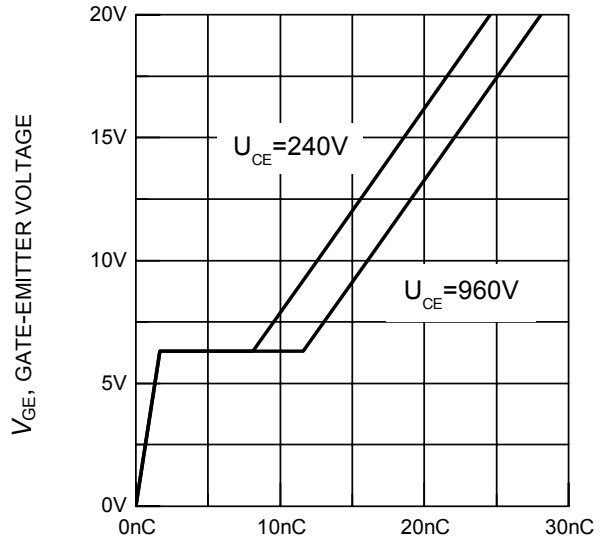




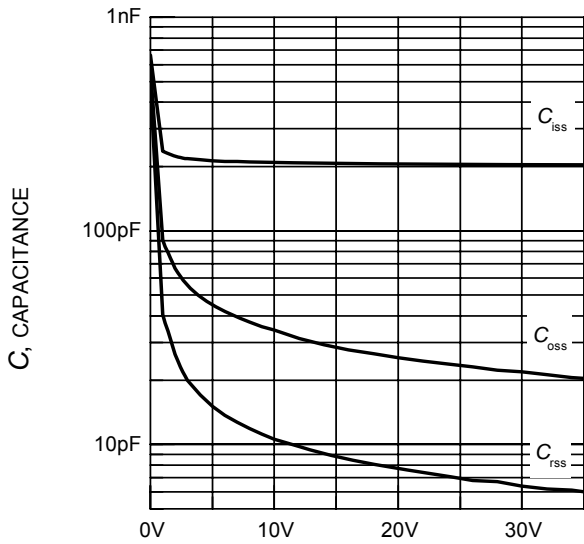
**IGP03N120H2**  
**IGW03N120H2**



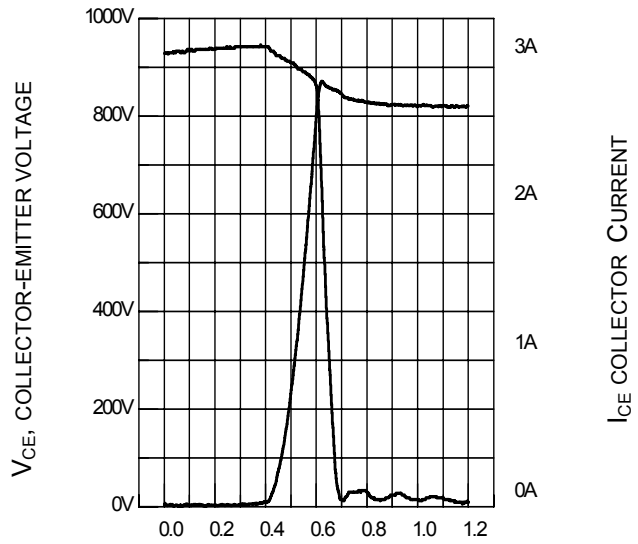
**Figure 16. IGBT transient thermal resistance**  
( $D = t_p / T$ )



**Figure 17. Typical gate charge**  
( $I_C = 3A$ )



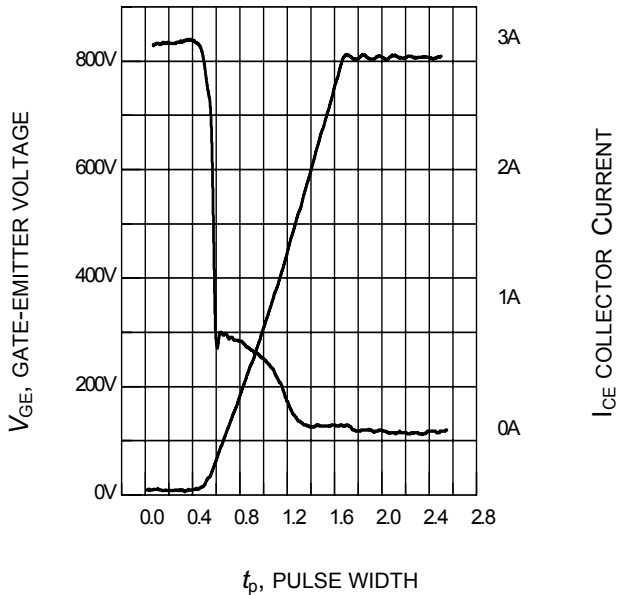
**Figure 18. Typical capacitance as a function of collector-emitter voltage**  
( $V_{GE} = 0V, f = 1MHz$ )



**Figure 20. Typical turn off behavior, hard switching**  
( $V_{GE} = 15/0V, R_G = 82\Omega, T_J = 150^\circ C,$   
Dynamic test circuit in Figure E)



IGP03N120H2  
 IGW03N120H2



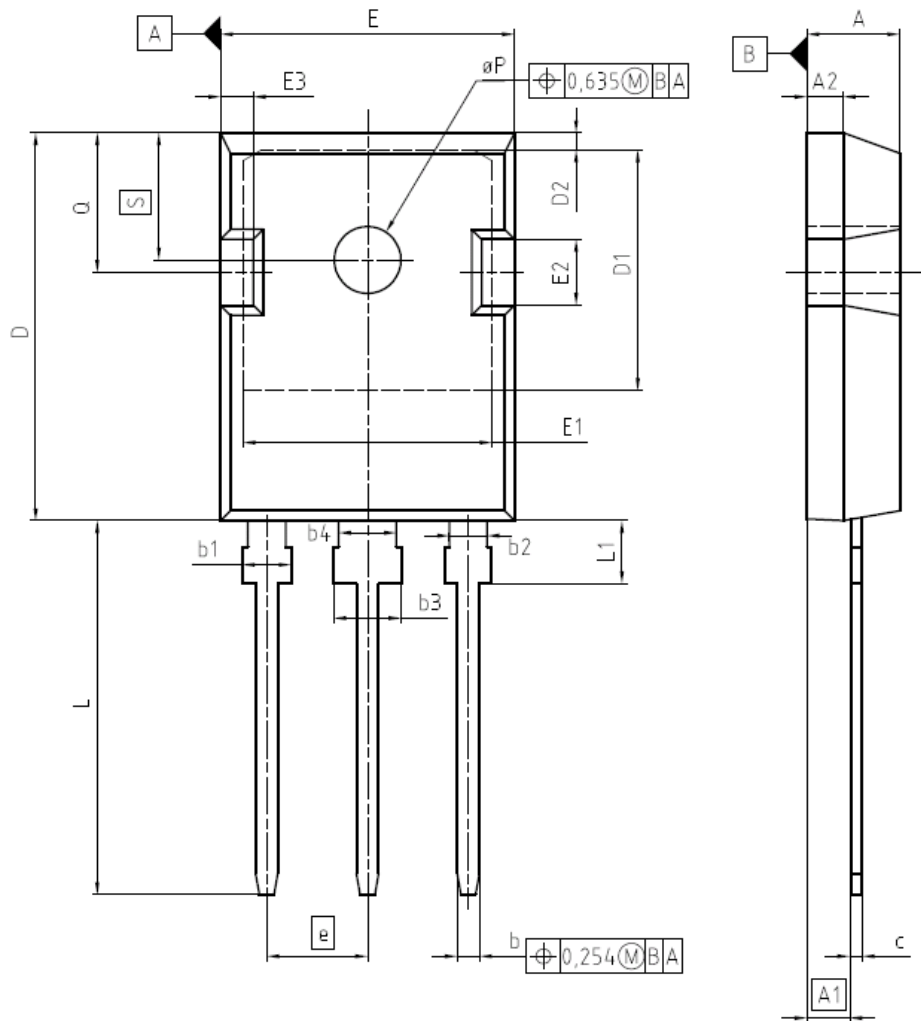
**Figure 21. Typical turn off behavior, soft switching**

( $V_{GE}=15/0V$ ,  $R_G=82\Omega$ ,  $T_j = 150^\circ C$ ,  
 Dynamic test circuit in Figure E)



**IGP03N120H2**  
**IGW03N120H2**

PG-TO247-3



| DIM      | MILLIMETERS |       | INCHES |       |
|----------|-------------|-------|--------|-------|
|          | MIN         | MAX   | MIN    | MAX   |
| A        | 4,90        | 5,16  | 0,193  | 0,203 |
| A1       | 2,27        | 2,53  | 0,089  | 0,099 |
| A2       | 1,85        | 2,11  | 0,073  | 0,083 |
| b        | 1,07        | 1,33  | 0,042  | 0,052 |
| b1       | 1,90        | 2,41  | 0,075  | 0,095 |
| b2       | 1,90        | 2,16  | 0,075  | 0,085 |
| b3       | 2,87        | 3,38  | 0,113  | 0,133 |
| b4       | 2,87        | 3,13  | 0,113  | 0,123 |
| c        | 0,55        | 0,68  | 0,022  | 0,027 |
| D        | 20,82       | 21,10 | 0,820  | 0,831 |
| D1       | 16,25       | 17,65 | 0,640  | 0,695 |
| D2       | 1,05        | 1,35  | 0,041  | 0,053 |
| E        | 15,70       | 16,03 | 0,618  | 0,631 |
| E1       | 13,10       | 14,15 | 0,516  | 0,557 |
| E2       | 3,68        | 5,10  | 0,145  | 0,201 |
| E3       | 1,68        | 2,60  | 0,066  | 0,102 |
| e        | 5,44        |       | 0,214  |       |
| N        | 3           |       | 3      |       |
| L        | 19,80       | 20,31 | 0,780  | 0,799 |
| L1       | 4,17        | 4,47  | 0,164  | 0,176 |
| $\phi P$ | 3,50        | 3,70  | 0,138  | 0,146 |
| Q        | 5,49        | 6,00  | 0,216  | 0,236 |
| S        | 6,04        | 6,30  | 0,238  | 0,248 |

DOCUMENT NO.  
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SCALE

EUROPEAN PROJECTION

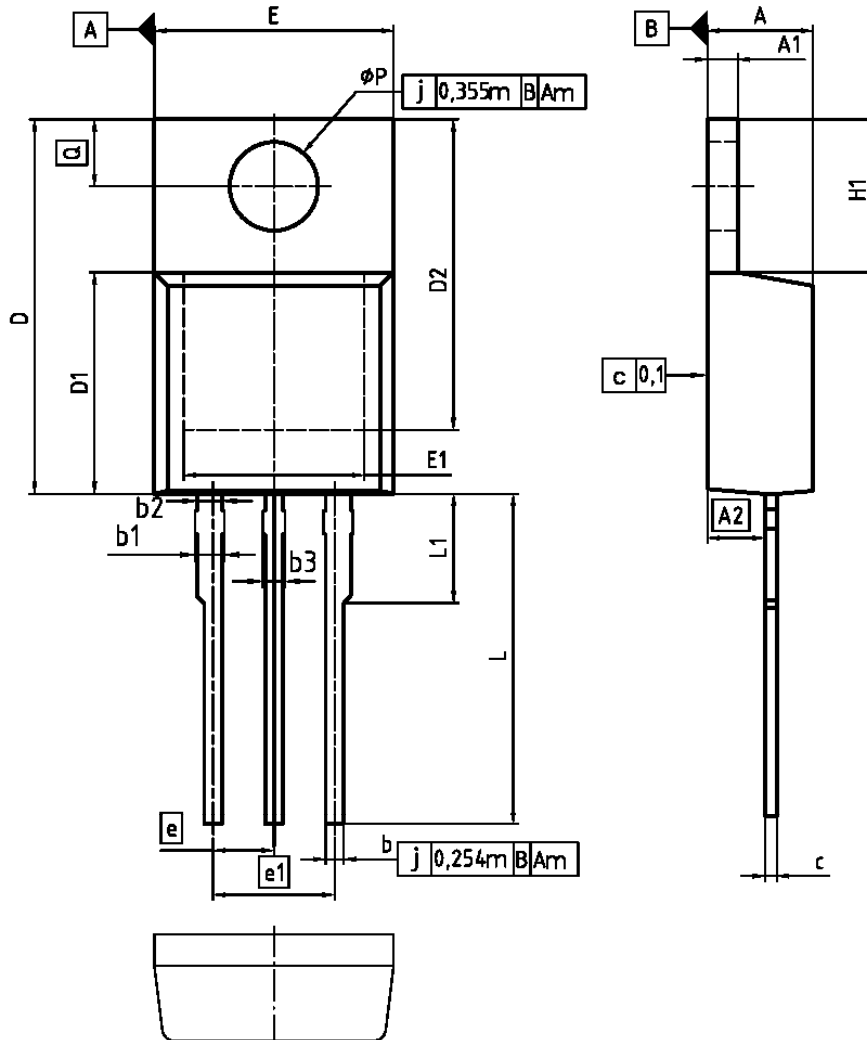
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REVISION  
03



**IGP03N120H2**  
**IGW03N120H2**

PG-TO220-3-1



| DIM | MILLIMETERS |       | INCHES |       |
|-----|-------------|-------|--------|-------|
|     | MIN         | MAX   | MIN    | MAX   |
| A   | 4.30        | 4.57  | 0.169  | 0.180 |
| A1  | 1.17        | 1.40  | 0.046  | 0.055 |
| A2  | 2.15        | 2.72  | 0.085  | 0.107 |
| b   | 0.65        | 0.86  | 0.026  | 0.034 |
| b1  | 0.95        | 1.40  | 0.037  | 0.055 |
| b2  | 0.95        | 1.15  | 0.037  | 0.045 |
| b3  | 0.85        | 1.15  | 0.028  | 0.045 |
| c   | 0.33        | 0.80  | 0.013  | 0.024 |
| D   | 14.81       | 15.95 | 0.583  | 0.628 |
| D1  | 8.51        | 9.45  | 0.335  | 0.372 |
| D2  | 12.19       | 13.10 | 0.480  | 0.518 |
| E   | 9.70        | 10.36 | 0.382  | 0.408 |
| E1  | 6.50        | 8.60  | 0.256  | 0.339 |
| e   | 2.54        |       | 0.100  |       |
| e1  | 5.08        |       | 0.200  |       |
| N   | 3           |       | 3      |       |
| H1  | 5.90        | 6.90  | 0.232  | 0.272 |
| L   | 13.00       | 14.00 | 0.512  | 0.551 |
| L1  | -           | 4.80  | -      | 0.189 |
| øP  | 3.80        | 3.88  | 0.142  | 0.153 |
| Q   | 2.60        | 3.00  | 0.102  | 0.118 |

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SCALE

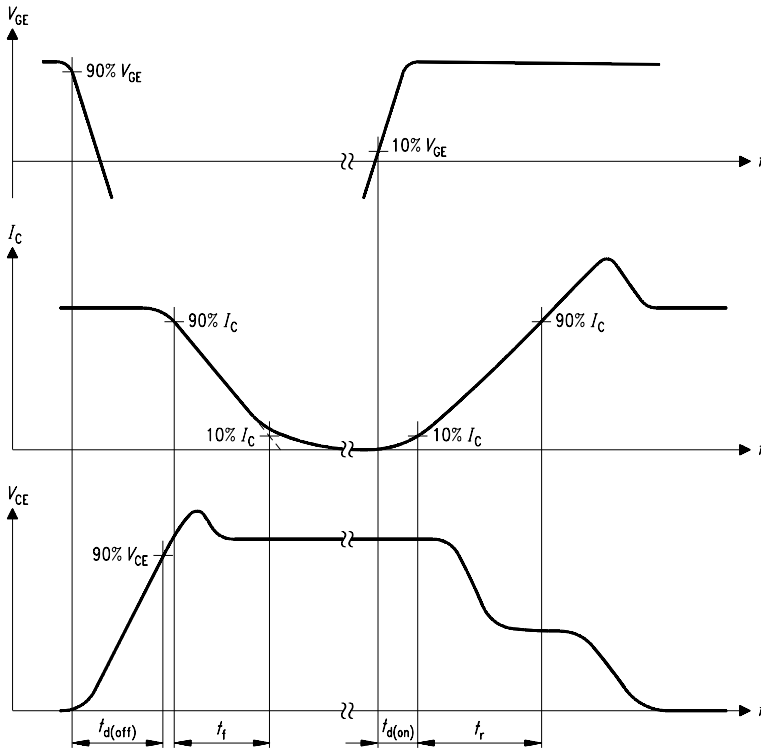
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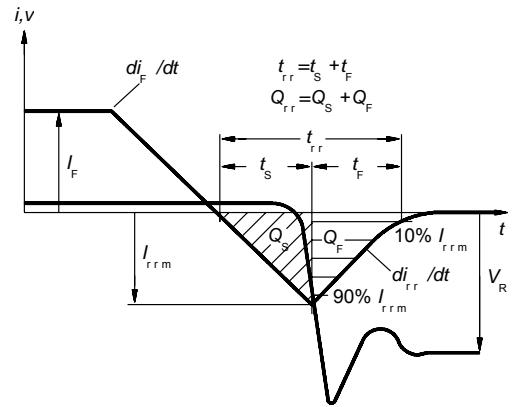
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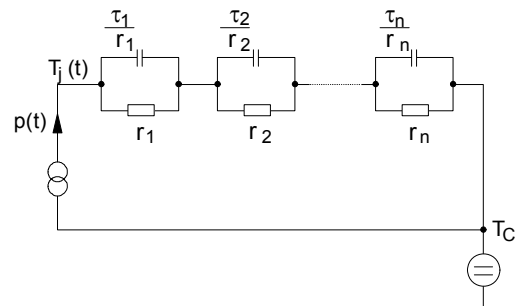
**IGP03N120H2**  
**IGW03N120H2**



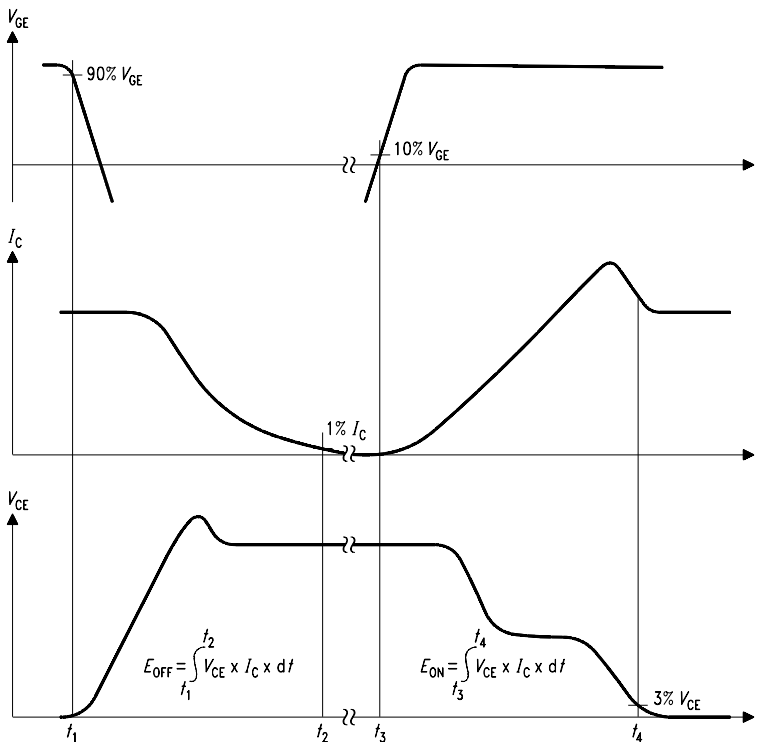
**Figure A. Definition of switching times**



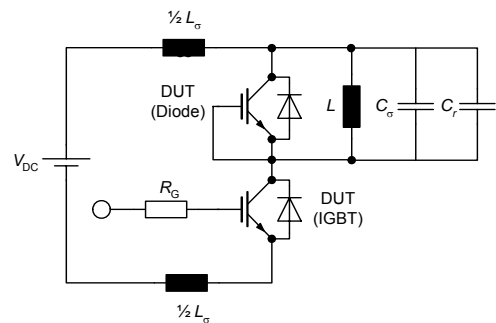
**Figure C. Definition of diodes switching characteristics**



**Figure D. Thermal equivalent circuit**



**Figure B. Definition of switching losses**



**Figure E. Dynamic test circuit**  
Leakage inductance  $L_{\sigma} = 180\text{nH}$ ,  
Stray capacitor  $C_{\sigma} = 40\text{pF}$ ,  
Relief capacitor  $C_r = 4\text{nF}$  (only for ZVT switching)



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